ECE 137 B: Notes Set 3 Common-emitter/source with emitter/source degeneration

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High-frequency analysis of emitter degeneration

How to treat the effect of emitter degeneration R_{EAC} on high-frequency transfer function.

To simplify the analysis, we will add an additional small capacitor C_E , that may or may not actually be present in the circuit; if it is not, then the analysis is approximate.



The answer, before we get started

We will show that a transistor in common emitter mode, with emitter degeneration.

Can be modelled as a transistor, without emitter degeneration.

Where

 $\frac{\tilde{C}_{be}}{C_{be}} = \frac{\tilde{g}_m}{g_m} = \frac{R_{be}}{\tilde{R}_{be}} = \frac{R_{ce}}{\tilde{R}_{ce}} = \frac{1}{1 + g_m R_{EAC}}$ note that all impedances got bigger, and all admittances got smaller, by the same ratio.

Except that
$$C_{cb}$$
 did not change



The answer, before we get started

We will show that a transistor in common source mode, with source degeneration.

Can be modelled as a transistor, without source degeneration.

Where

$$\frac{\tilde{C}_{gs}}{C_{gs}} = \frac{\tilde{g}_m}{g_m} = \frac{R_{DS}}{\tilde{R}_{DS}} = \frac{1}{1 + g_m R_{SAC}}$$

note that all impedances got bigger, and all admittances got smaller, by the same ratio.

Except that C_{gd} did not change.



The sub-circuit to be analyzed

Model of bipolar transistor with emitter degeneration.

Note that C_{cb} can be temporarily removed (disconnected) from the network, ...and then put back later.

This is why degeneration does not change the effective value of C_{cb} .





Deriving high-frequency model of emitter degeneration

Simplify the problem by setting
$$R_{be} = R_{CE} = \infty \Omega$$

Key assumption: $R_{EAC}C_E = C_{be} / g_m$

$$Z_{E} = R_{EAC} ||(1 / sC_{E})| = \frac{R_{EAC}}{1 + sR_{EAC}C_{E}} = \frac{R_{EAC}}{1 + sC_{be} / g_{m}}$$

Apply input current I_{in} step 1: $V_{he} = I_{in} / sC_{he}$ step 2: $I_{out} = I_C = g_m V_{be} = I_{in} \cdot g_m / sC_{be}$ step 3: $I_{E} = I_{out} + I_{in} = I_{in}(1 + g_{m} / sC_{he})$ step 4: $V_E = I_E Z_E = \frac{R_{EAC} I_{in} (1 + g_m / sC_{be})}{1 + sC_{be} / g_m}$ $=\frac{g_{m}}{sC_{i}}\frac{R_{EAC}I_{in}(1+sC_{be}/g_{m})}{1+sC_{i}/g}=\frac{g_{m}R_{EAC}}{sC_{i}}I_{in}$ step 5: $V_{in} = V_{be} + V_E = \frac{I_{in}}{sC_i} + \frac{g_m R_{EAC}}{sC_i} I_{in} = I_{in} \left(\frac{1 + g_m R_{EAC}}{sC_i} \right)$ $\frac{V_{in}}{L} = Z_{in} = \left(\frac{1}{s\tilde{C}_{in}}\right)$ where $\tilde{C}_{be} = \frac{C_{be}}{1+g_{in}R_{max}}$



Deriving high-frequency model of emitter degeneration

$$\frac{V_{in}}{I_{in}} = Z_{in} = \left(\frac{1}{s\tilde{C}_{be}}\right) \text{ where } \tilde{C}_{be} = \frac{C_{be}}{1 + g_m R_{EAC}}$$

step 7:
$$I_{out} = g_m V_{be} = \frac{g_m}{sC_{be}} I_{in} = \frac{g_m}{sC_{be}} \frac{V_{in}}{Z_{in}} = g_m V_{in} \frac{s\tilde{C}_{be}}{sC_{be}}$$

$$I_{out} = V_{in} \frac{g_m}{1 + g_m R_{EAC}}$$

$$I_{out} = \tilde{g}_m V_{in}$$
 where $\tilde{g}_m = \frac{g_m}{1 + g_m R_{EAC}}$



Deriving high-frequency model of emitter degeneration

So this...

В **-0** C V_{be} Ε R_{EAC} C_E \widetilde{C}_{be} $C_{cb} \ \widetilde{g}_m V_{in}$ В V_{in}

 $C_{cb} g_m V_{be}$

 C_{be}



and

$$\tilde{g}_m = \frac{g_m}{1 + g_m R_{EAC}}$$

...has the same characteristics as (can be replaced by) this.

Combining this with the low-frequency result:

A transistor in common emitter mode, with emitter degeneration.

Can be modelled as a transistor, without emitter degeneration.

Where

 $\frac{\tilde{C}_{be}}{C_{be}} = \frac{\tilde{g}_m}{g_m} = \frac{R_{be}}{\tilde{R}_{be}} = \frac{R_{ce}}{\tilde{R}_{ce}} = \frac{1}{1 + g_m R_{EAC}}$ note that all impedances got bigger, and all admittances got smaller, by the same ratio.

Except that C_{cb} *did not change*



What about the capacitor C_E ?

We have added the capacitor C_E with the assumption $R_{EAC}C_E = C_{be} / g_m$

Note that $R_{EAC}C_E < 1/2\pi f_{\tau}$; a very small time constant. \rightarrow Removing C_E only has significant effect at frequencies near f_{τ}



What about the capacitor C_E ?

It is too detailed for ECE137B, but a more careful analysis shows that, if C_E is not present, then the circuit can be accurately modelled as shown to the right.

Note the presence of R_{EAC} in the *base* of the resulting equivalent circuit.

$$\frac{\tilde{C}_{be}}{C_{be}} = \frac{\tilde{g}_m}{g_m} = \frac{R_{be}}{\tilde{R}_{be}} = \frac{R_{ce}}{\tilde{R}_{ce}} = \frac{1}{1 + g_m R_{EAC}}$$



Example (1)

For now, low-frequency rolloff due to DC blocking and emitter bypass capacitance is ignored.



Example (2): Mid-band equivalent circuit

For now, low-frequency rolloff due to DC blocking and emitter bypass capacitance is ignored.

 $V_{gen} / R_{gen} = V_{gen} / 1 \text{ k}\Omega$ $R_{inAmp} = 10 \text{ k}\Omega || 123 \text{ k}\Omega || 64 \text{ k}\Omega$ $R_i = R_{inAmp} || R_{gen} = R_{inAmp} || 1 \text{ k}\Omega = 890 \Omega$ $\tilde{g}_m V_{in} = \frac{V_{in}}{48 \Omega + 52 \Omega} = \frac{V_{in}}{100 \Omega}$ $R_{Leq} = R_{CE} || R_C || R_L \approx R_C || R_L = 1 \text{ k}\Omega || 8 \text{ k}\Omega = 890 \Omega$

Midband gain





Small-signal parameters $C_{cb} = 10 \text{ pF}$ $1/g_m = 26 \text{ mV}/0.5 \text{ mA} = 52 \Omega$ $C_{be} = g_m / 2\pi f_\tau - C_{cb} = 20.6 \text{ pF}$

Example (2): high-frequency response

Che = Che (Te / (Te + REAL)) = 20.6 pF (48/100) = 9.9 pF Ccb quilin Rieg CL 660 Ri Nin Jout(A) = - 8.9 1+ 6, A IDAF $v_{gen}(A) = 1 + a_1 A + a_2 A^2$ 890 12 890 B a1 = 890 R Cbe + 890 R (1+ gm Rieg) Ccs + 890 R (Cc6 + Cc) 9 = (100 A) = 114 45 61 = - 10pF / 9m = -10pF. 100 2 = -1 ns az = 890 A . 890 A 9.9 pF. 10 pF + 9.9 5F. 10 pF + 10 pF. 10 pF] = 2.36 (10) sec = (15.4 MS) Volvgen = -8.9 (1-A. Ins) (1+ A. 114MS + D2(15.4 ns)2) ~ - 8.9 1 - A(INS) USing SPA (1+ A. 114ns) (1+ A. Z. (ns)

Example (3): high-frequency response

$$\frac{V_{out}(j2\pi f)}{V_{in}(j2\pi f)} = -8.9 \cdot \frac{1 - jf / 160 \text{ MHz}}{(1 + jf / 1.4 \text{ MHz})(1 + jf / 176 \text{ MHz})}$$

